



| The European Synchrotron



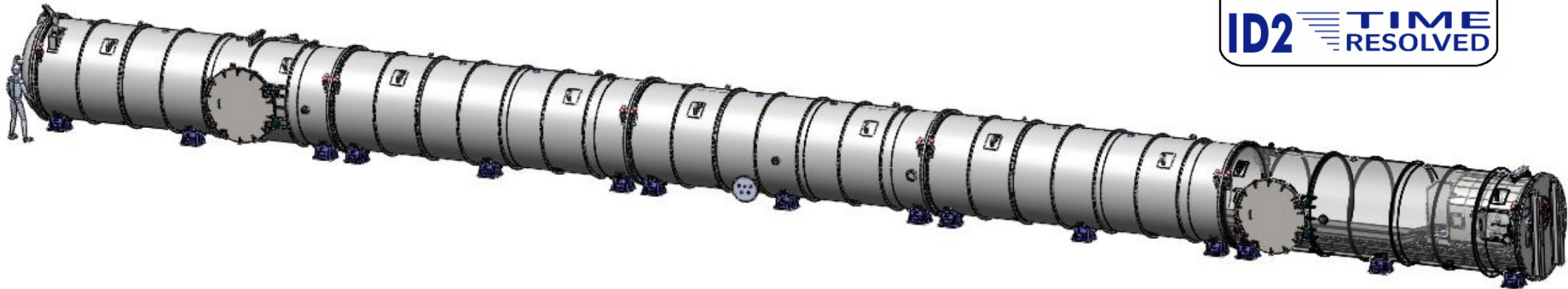
M. Sztucki

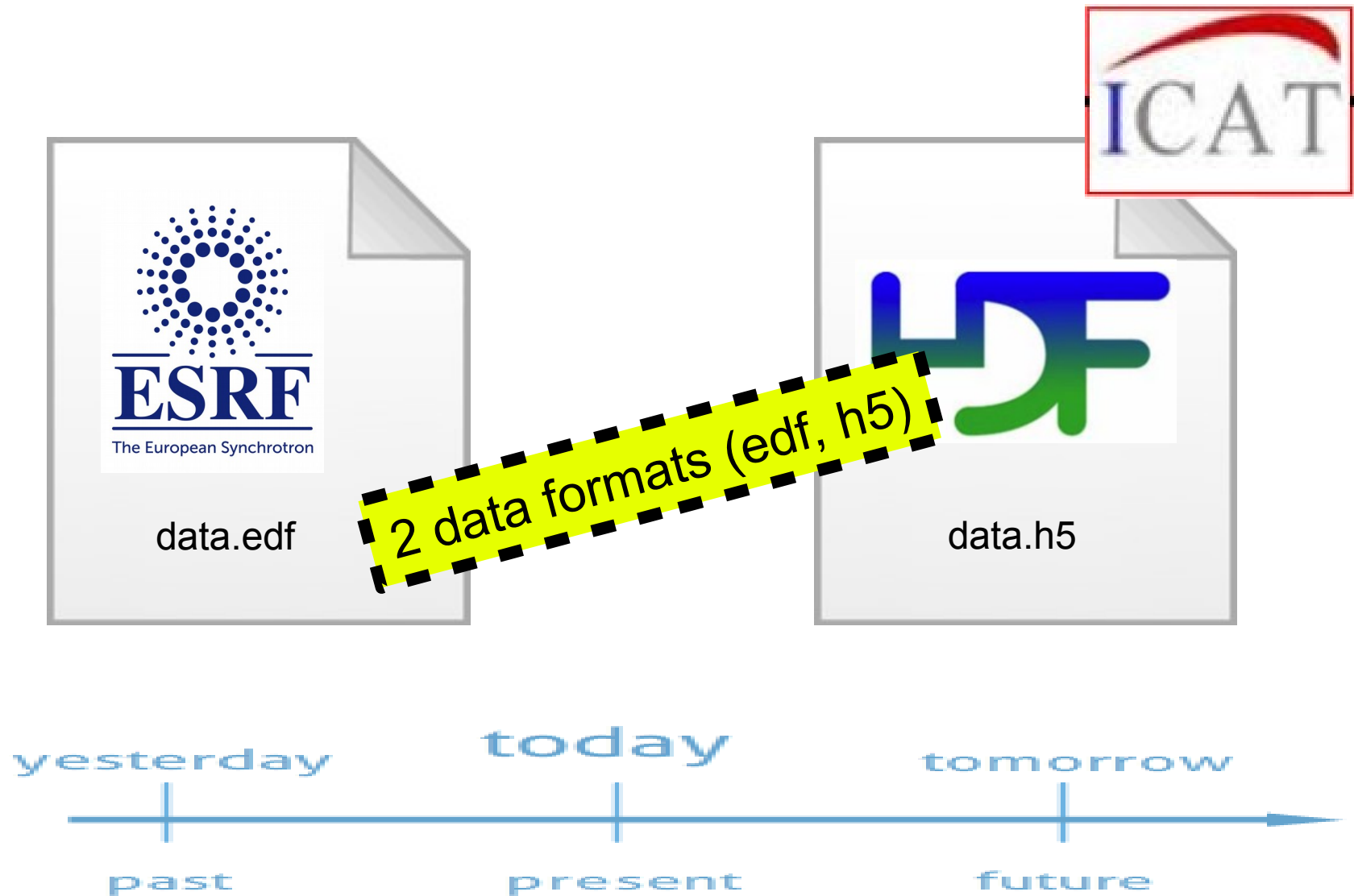
ESRF
the European Synchrotron
Grenoble (France)



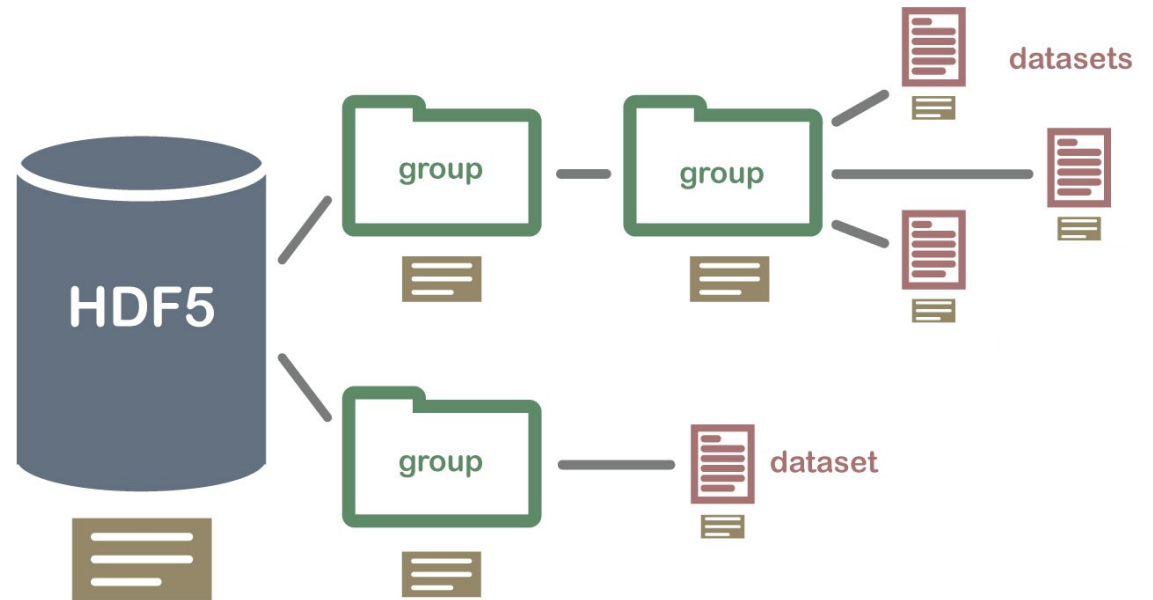
- **ID02 data and metadata concept**
 - **understanding of the data formats (EDF, HDF5)**
 - **detector dependent corrections (non-linearity, dark current, flat field, spatial distortion, etc.) as well as the normalisation to an absolute intensity scale and the azimuthal integration to obtain one dimensional SAXS profiles**
 - **data reduction schemes**
 - + SPD (saxs programs)
 - + DAHU (PyFAI)
-
- **SAXSutilities**
 - + 1D, 2D visualization
 - + 1D, 2D data reduction
 - **More advanced features include direct modelling (standard models in small-angle scattering)**

SAXS, WAXS and USAXS





[illegible]



ID02 data and metadata concept



data.h5



http://www.esrf.fr/files/live/sites/www/files/Instrumentation/software/data-analysis/OurSoftware/SAXS/SX_parametrization-ref-short_20130125.pdf

PETER BOESECKE SX_parametrization-ref-short_20130125.doc

2013-01-25

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SX General Parameters

- *Dim_1, Dim_2, ...* (*Dim_1* default is 0, all others are 1)
- *RasterOrientation* (1 to 8 possible, 9-16 for compatibility, needs to be tested, default 1)

SX Image Parameters

- *Offset_1, Offset_2, ...* (default: 0)
- *BSize_1, BSize_2, ...* (default: 1)

SX Scattering Parameters

- *PSize_1, PSize_2, ...* (no default) [m]
- *Center_1, Center_2, ...* (PoNI in image reference system including offsets, no default)
- *SampleDistance* (no default) [m]
- *WaveLength* (no default) [m]
- *DetectorRotation_1, DetectorRotation_2, DetectorRotation_3, ...* (default: 0) [rad]

Additional SX Scattering Parameters

- *ProjectionType* (Saxs|Waxs, default: Saxs: distances proportional to $\tan(2\theta)$)
- *AxisType_1, AxisType_2, ...* (Distance, Angle, Numerator, default: Distance)

SX Intensity Calibration and Normalization Parameters

- *Intensity0* (no default), *Intensity1* (*Intensity0*)
- *NormalizationFactor* (default 1)
- *SampleThickness* (no default)

special case ehf/edf files

```

1 {
2 EDF_DataBlockID = 1.Image.Psd ;
3 EDF_BinarySize = 1440256 ;
4 EDF_HeaderSize = 8192 ;
5 ByteOrder = LowByteFirst ;
6 DataType = FloatValue ;
7 Dim_1 = 1000 ;
8 Dim_2 = 360 ;
9 Dummy = -10 ;
10 DDummy = 0.1 ;
11 Offset_1 = 0 ;
12 Offset_2 = 0 ;
13 History-1 = ""C:\\Program Files (x86)\\SAXSUtili
      C:\\Data\\SAXSUtilities_Testdata\\h5\\og22_
14 HeaderID = EH:000001:000000:000000 ;
15 Compression = None ;
16 Image = 1 ;
17 SaxsDataVersion = 2.40 ;
18 Size = 1440256 ;
19
20
21
22
23
24
25 }
26 '7+Á'7+Á'7+Á'7+Á'7+Á'7+
      '7+Á'7+Á'7+Á'7+Á'7+
      '7+Á'7+Á'7+Á'7+Á'7+

```

| | |
|--------------------------------------------|---|
| Peter Boesecke | |
| SaxsKeywords.doc | |
| 2013-01-25 | |
| | |
| Keywords for SAXS Data in EDF Files | |
| | |
| EDF_DataFormatVersion = 2.42 | |
| | |
| Peter Boesecke | |
| Keywords for SAXS Data in EDF Files | 1 |
| EDF_DataFormatVersion | 1 |
| Peter Boesecke | 1 |
| Keywords | 6 |
| Types of Header Values | 6 |
| String Value | 7 |
| Types of Header Values | 7 |
| String Value | 8 |

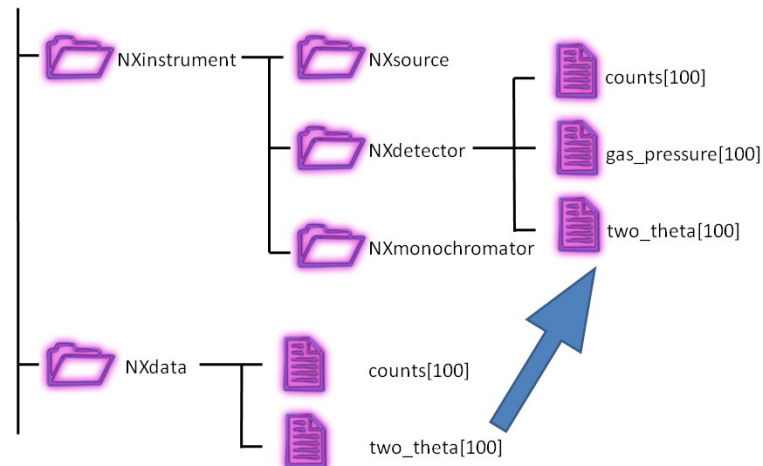
<http://www.esrf.fr/files/live/sites/www/files/Instrumentation/software/data-analysis/OurSoftware/SAXS/SaxsKeywords-V2.459P2.033E2.229.pdf>



<https://www.hdfgroup.org>



<http://www.nexusformat.org>



ESRF NeXus files

NXroot top level, one per file

NXentry one group per measurement

NXinstrument only one per NXentry

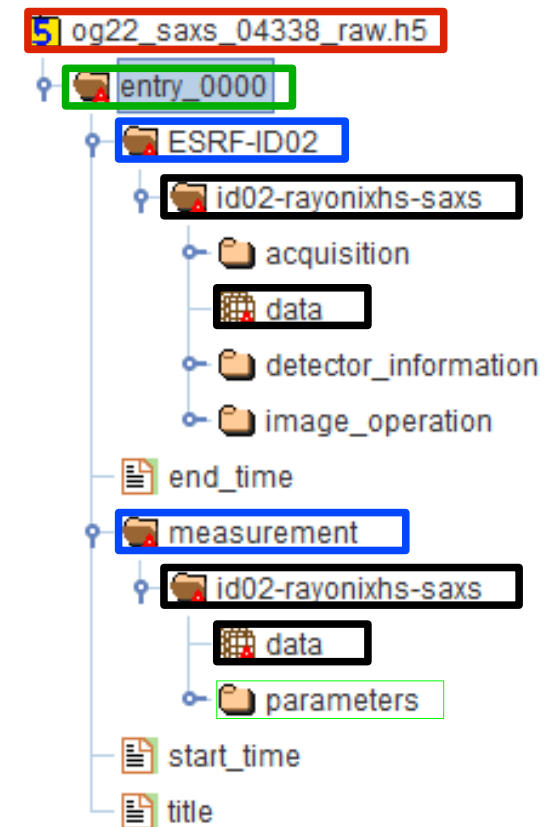
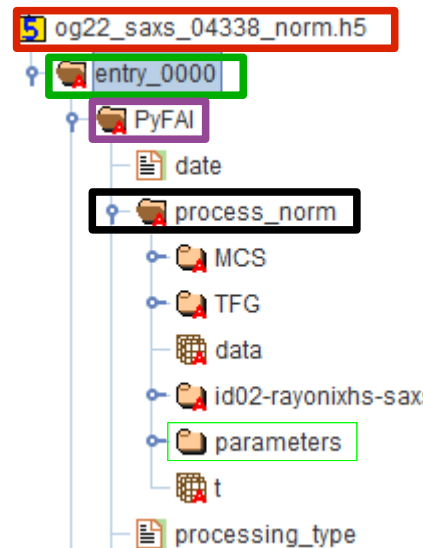
NXdetector

NXdata one NXdata group per plot

measurement (@NXcollection) flattened view of everything measured - only one per NXentry

NXsample
user (@NXuser)

NXprocess for analysis



understanding of the data formats (EDF, HDF5)

raw data (*_raw.h5) [NXdata]:

/entry_0000/measurement/id02-XXXX/data

raw metadata (*_raw.h5)

/entry_0000/measurement/id02-XXXX/parameters

raw metadata (*_scalers_*_raw.h5)

/entry_0000/id02/MCS

/entry_0000/id02/TFG

/entry_0000/id02/parameters

Note: static and dynamic metadata
are written in two different files

processed data [NXdata]:

/entry_0000/PyFAI/process_XXXX/data

/entry_0000/PyFAI/process_XXXX/q

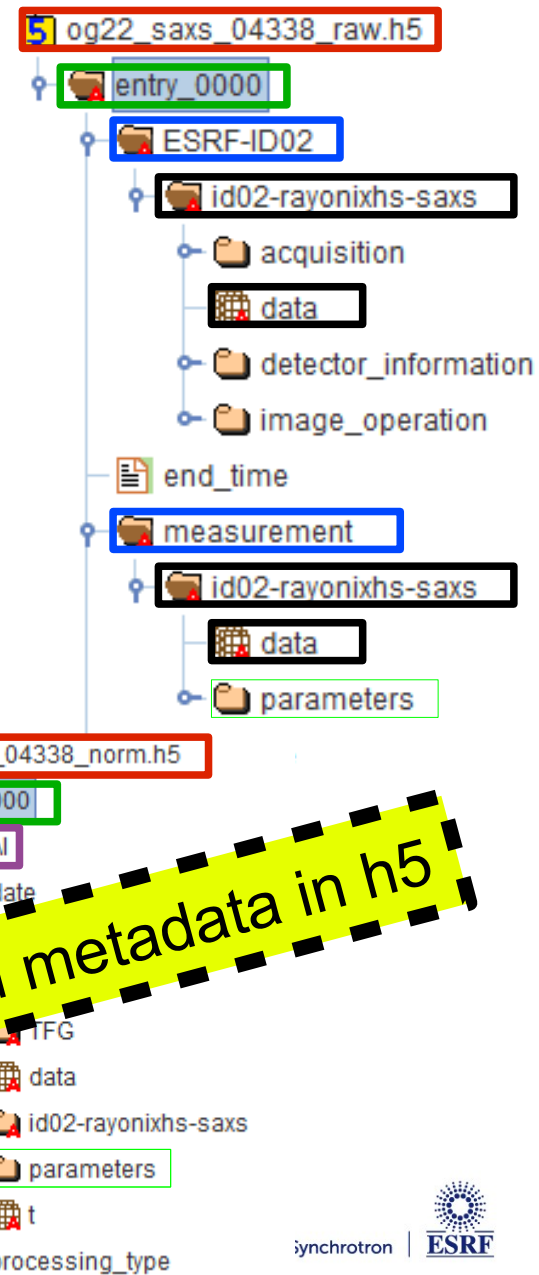
/entry_0000/PyFAI/process_XXXX/t

processed metadata:

/entry_0000/PyFAI/process_XXXX/parameters

/entry_0000/PyFAI/process_XXXX/MCS

/entry_0000/PyFAI/process_XXXX/TFG



locating data and metadata in h5



- (A) detector specific corrections
- (B) scattering specific corrections
- (C) sample and beam specific corrections

(A) detector specific corrections

| | | |
|--------------------------------|------------|----------------------------------------------------------|
| CCD raw image [ADU] | i_{raw} | } identical exposure times (corrected for distortion) |
| CCD dark image [ADU] | i_{dark} | |
| Flat field image [photons/ADU] | f_2 | |

1. Dark image subtraction [ADU] $i_1 = i_{raw} - i_{dark}$
2. Spatial distortion correction [ADU] $I_2 = SPD(I_1)$
3. Division by flatfield [photons] $i_3 = i_1 / f_2$

- Subtraction and division are done pixel by pixel
- The spatial distortion correction consists of a horizontal and vertical displacement of each pixel

(B) scattering specific corrections

4. Normalization to I_0 [photons] and
conversion to scattering cross section [1/sterad]

inclined
surface

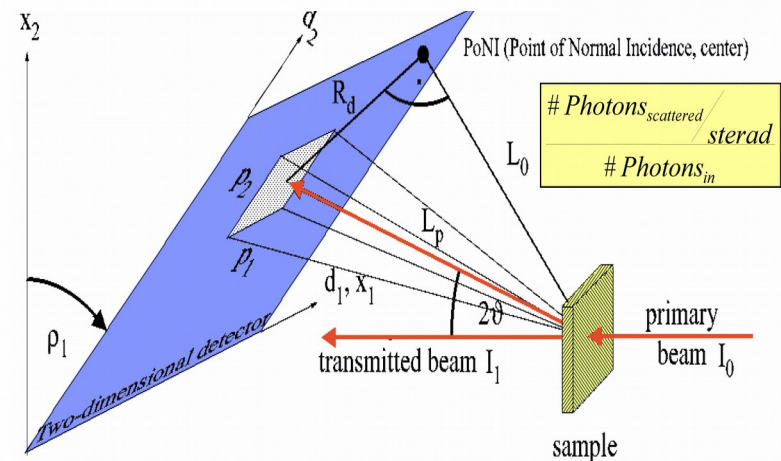
$$\left(\frac{1}{A}\right) \frac{\partial \sigma}{\partial \Omega} = \frac{\# Photons_{scattered} / sterad}{\# Photons_{in}}$$

$$i_4 = \frac{i_3}{I_0} \cdot \frac{L_p^2}{p_1 \cdot p_2} \cdot \frac{L_p}{L_0}$$

shortest sample to detector distance L_0
sample to pixel distance L_p
pixel size p_1, p_2

$1/\Delta\Omega$

(see Bösecke, Diat, J. Appl. Cryst. (1997). 30, 867-871
and Narayanan, Diat, Bösecke, NIM A 467-468 (2001) 1005-1009)



5. Normalization to transmission and scattering volume, e.g. thin film:
T=I1/I0, d: sample thickness

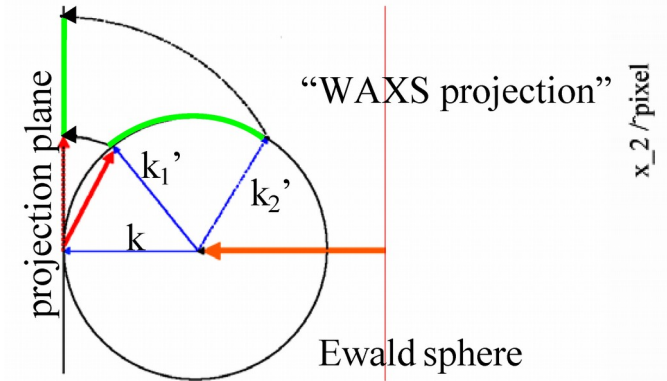
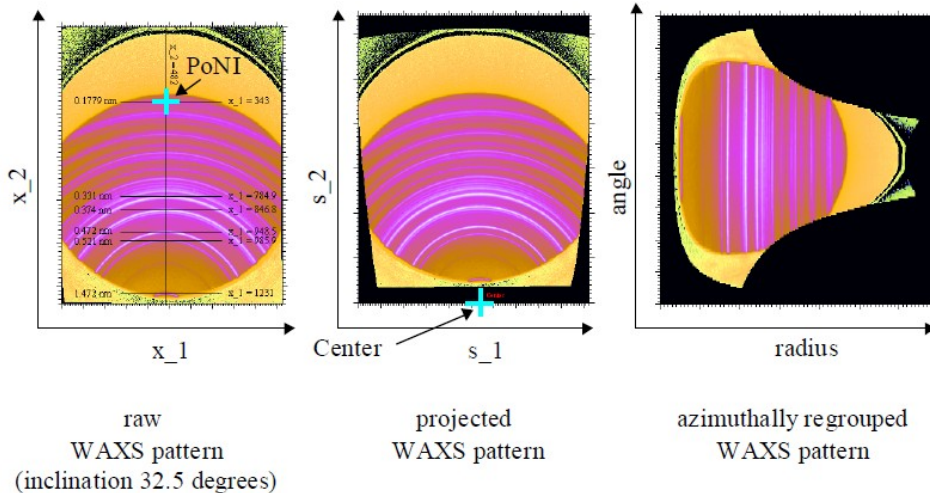
$$i_5 = \frac{i_3}{d \cdot I_1} \cdot \frac{L_p^2}{p_1 \cdot p_2} \cdot \frac{L_p}{L_0}$$

6. Polarization correction (WAXS)

7. Reciprocal space mapping (WAXS)
(Ewald sphere projections in reciprocal space, sample orientation required)

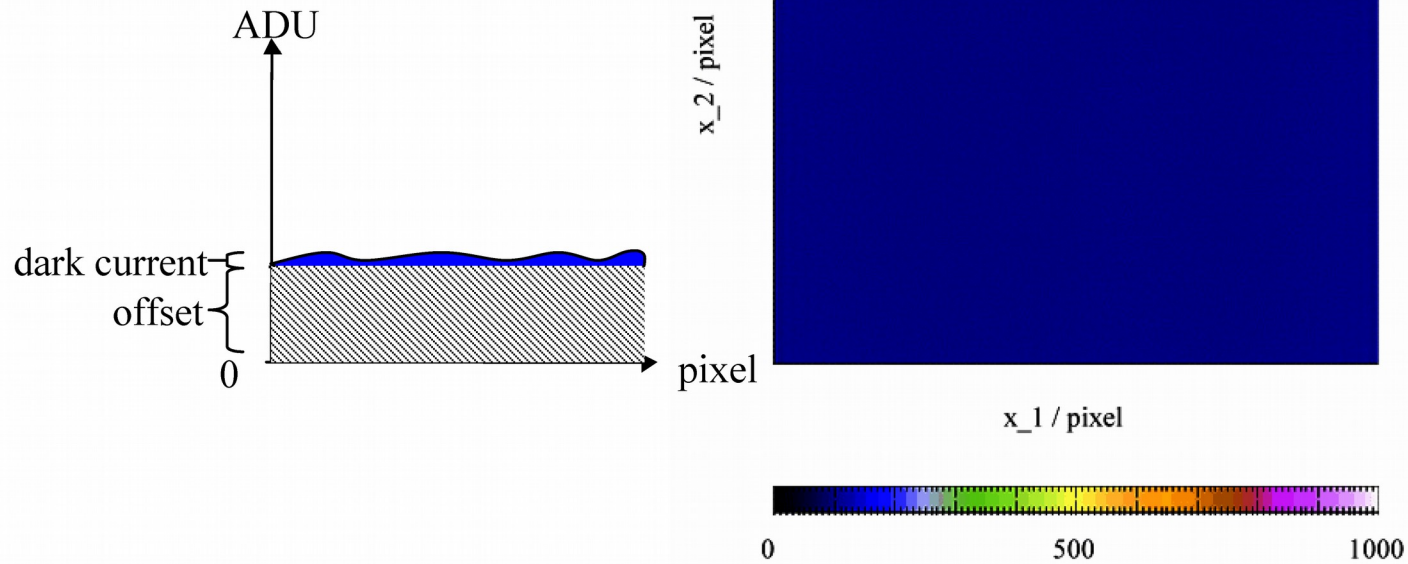
8. Azimuthal averaging

WAXS projection

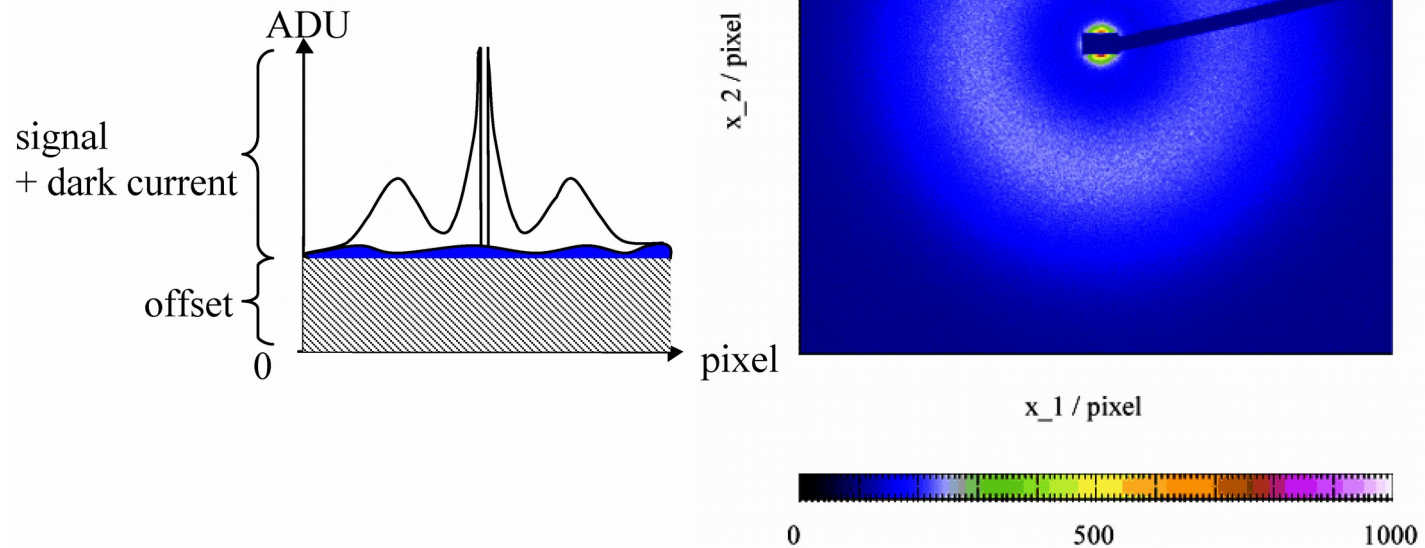


In Waxs projection the scattering pattern of a tilted detector can be geometrically analysed (azimuthal regrouping etc.) like a small angle scattering pattern.

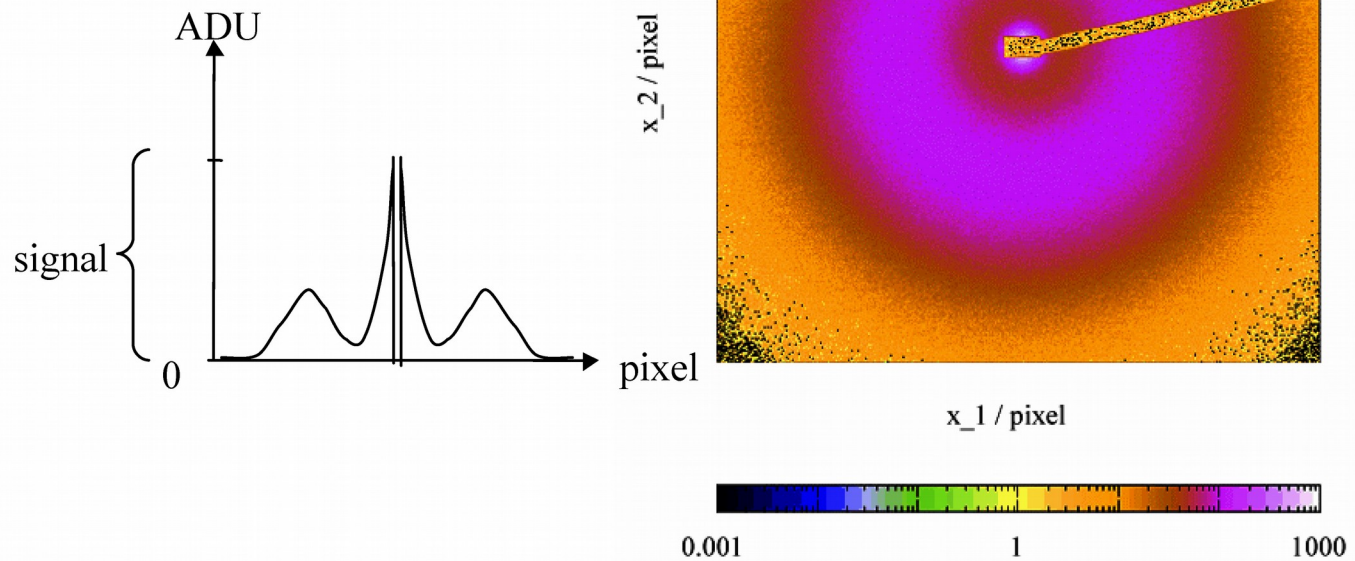
1. dark image



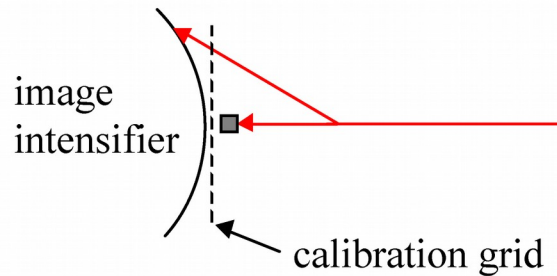
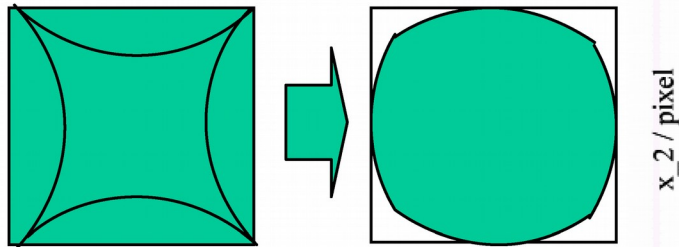
2. raw image



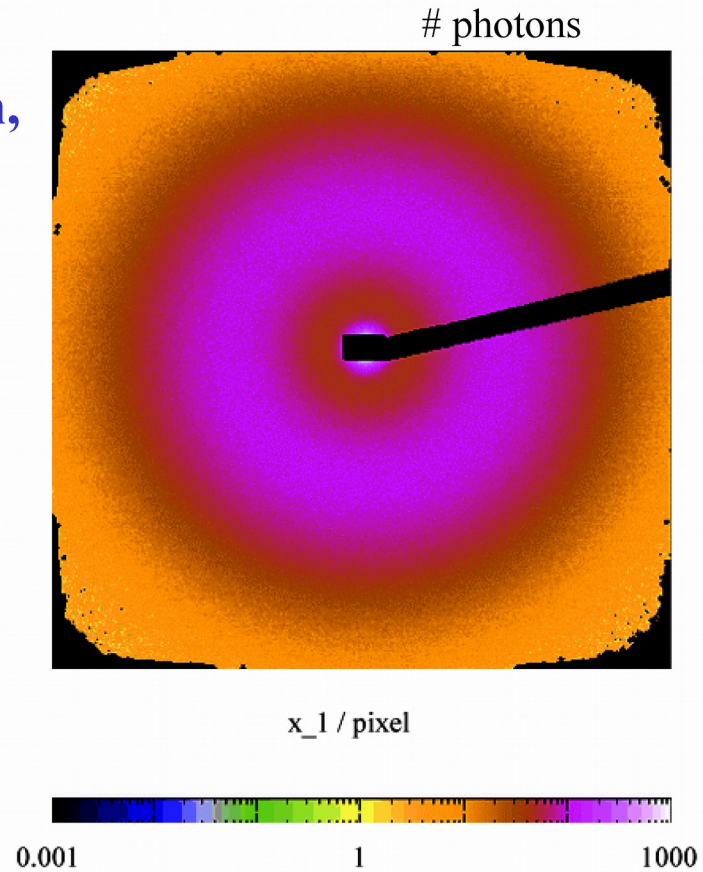
3. raw image - dark image



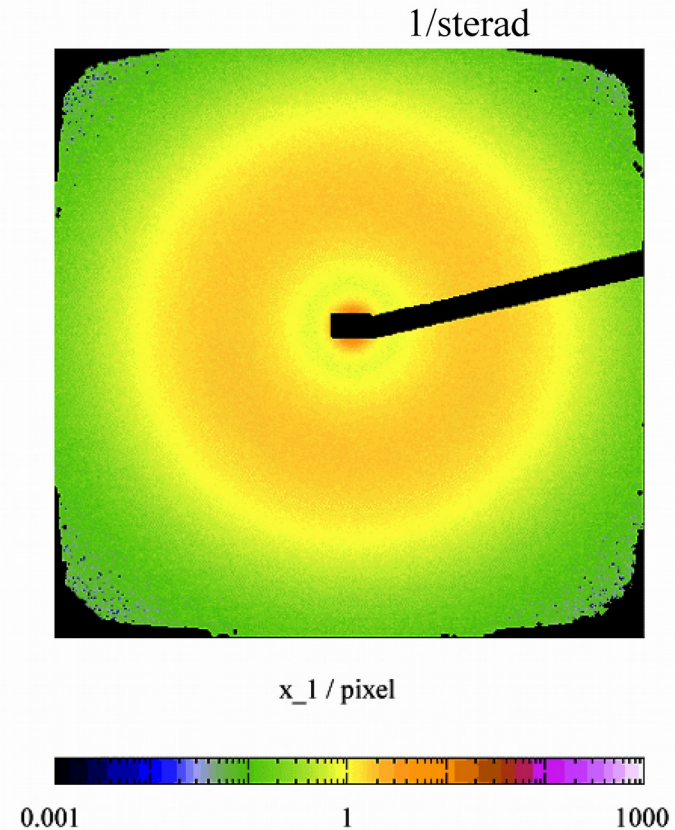
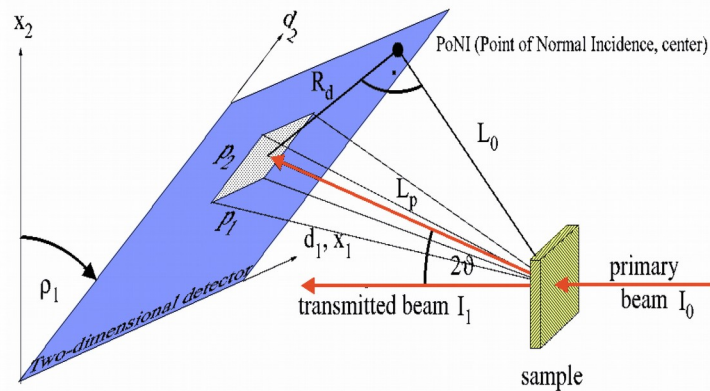
4. spatial distortion correction, division by flatfield, masking



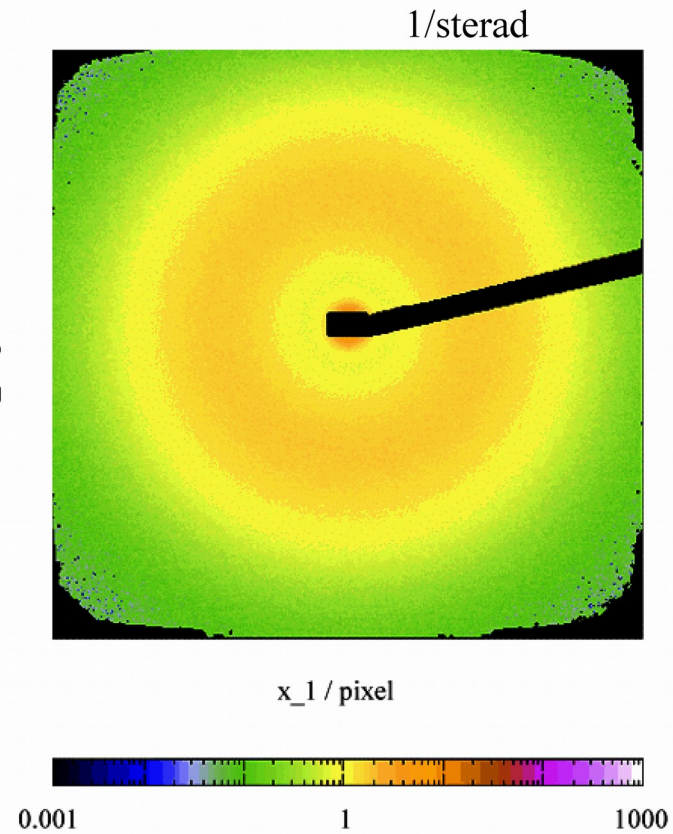
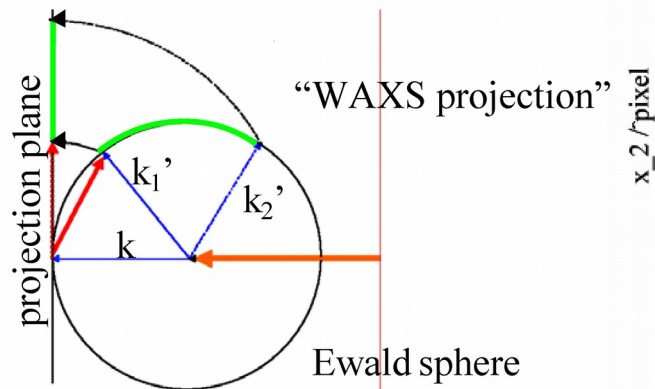
x_2 / pixel



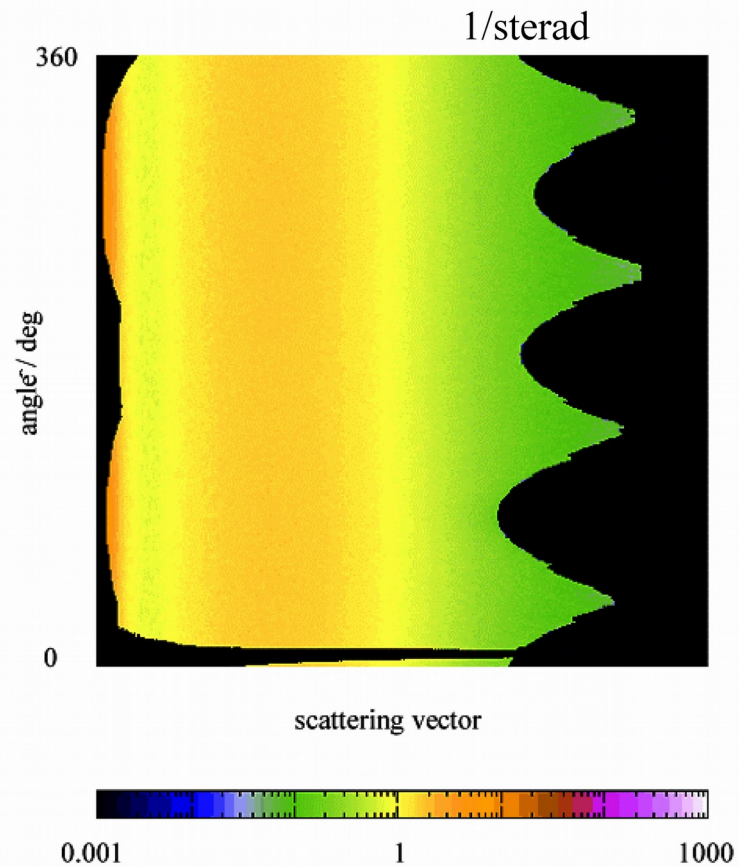
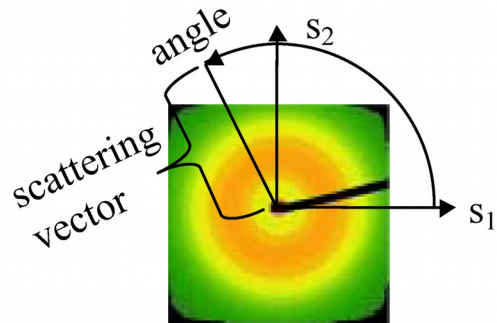
5. normalization to absolute scattering units



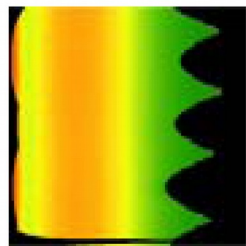
(6. Ewald sphere projection)



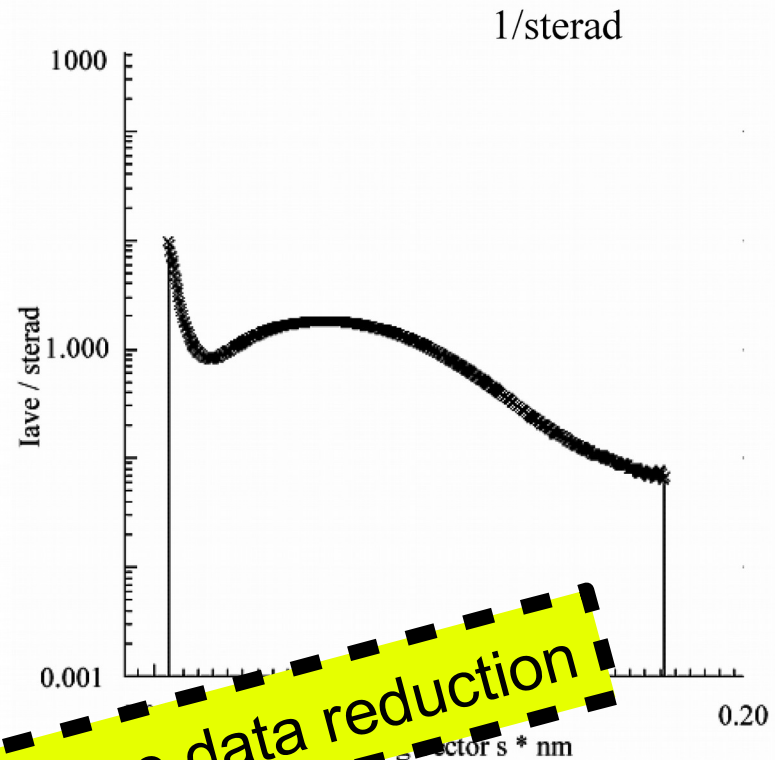
7. azimuthal regrouping



8. azimuthal averaging



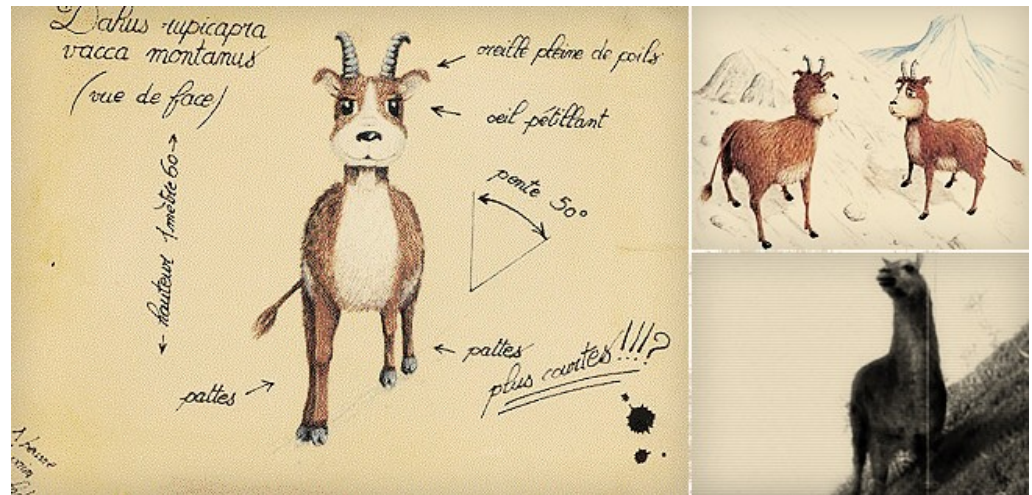
averaging



all automatised in online data reduction

+ SPD (saxs programs)

+ DAHU (PyFAI)



→ project for 2016: online variance calculation in PyFAI

<http://www.esrf.fr/Instrumentation/software/data-analysis/OurSoftware/SAXS/SaxsDownloads.html>

ID02 online data reduction (SPD) package was developed by P. Boesecke, A. Sole and R. Wilcke during 2001-2005

saxs programs are command line oriented programs (C) to perform certain tasks for data reduction

propagation of statistical errors

GUI is available for most common tasks in SAXSutilities

example:

```
➤ saxs_normn -p -ofac 1.8/2.75 -omod n  
+pass +flat -i3nam flat.msk -scal  
-i1nam .. stp3_%%%.edf,2,39  
-onam stp3_%%%.nrm -obin 4 4
```

| Program name | Short description |
|--------------------------------------------------|---------------------------------------------------------------------------------------------------------------|
| saxs_mac | standard operations on images, e.g. multiply by factor and add constant |
| saxs_add, saxs_sub, saxs_mul, saxs_div | add, subtract, multiply, divide several images |
| saxs_normn | flatfield correction and normalization of scattering patterns to absolute units in 1/sterad |
| saxs_waxs saxs_angle saxs_row, saxs_col | waxs projection and backprojection transformation to polar coordinates row, column projection of images |
| saxs_ascii saxs_patch saxs_stat | convert images to ascii patch images to other images calculate image statistics |

P. Bösecke, "Reduction of two-dimensional small- and wide-angle X-ray scattering data," J. Appl. Cryst. 40, 423-427 (2007)

further info:

<http://www.esrf.fr/files/live/sites/www/files/Instrumentation/software/data-analysis/OurSoftware/SAXS/SaxsPrograms-V2.459P2.033E2.229.pdf>

| | | |
|--------------------------------------------------------|------------------|------------|
| PETER BOESECKE | SaxsPrograms.doc | 2013/01/25 |
| | | |
| OPTIONS AND ARGUMENTS OF THE SAXS PROGRAMS..... | 4 | |
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| Introduction | 4 | |
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| Arguments | 5 | |
| Options | 5 | |
| Examples | 6 | |
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| Arithmetic Expressions as Values | 13 | |

P. Bösecke, "Reduction of two-dimensional small- and wide-angle X-ray scattering data," J. Appl. Cryst. 40, 423-427 (2007)

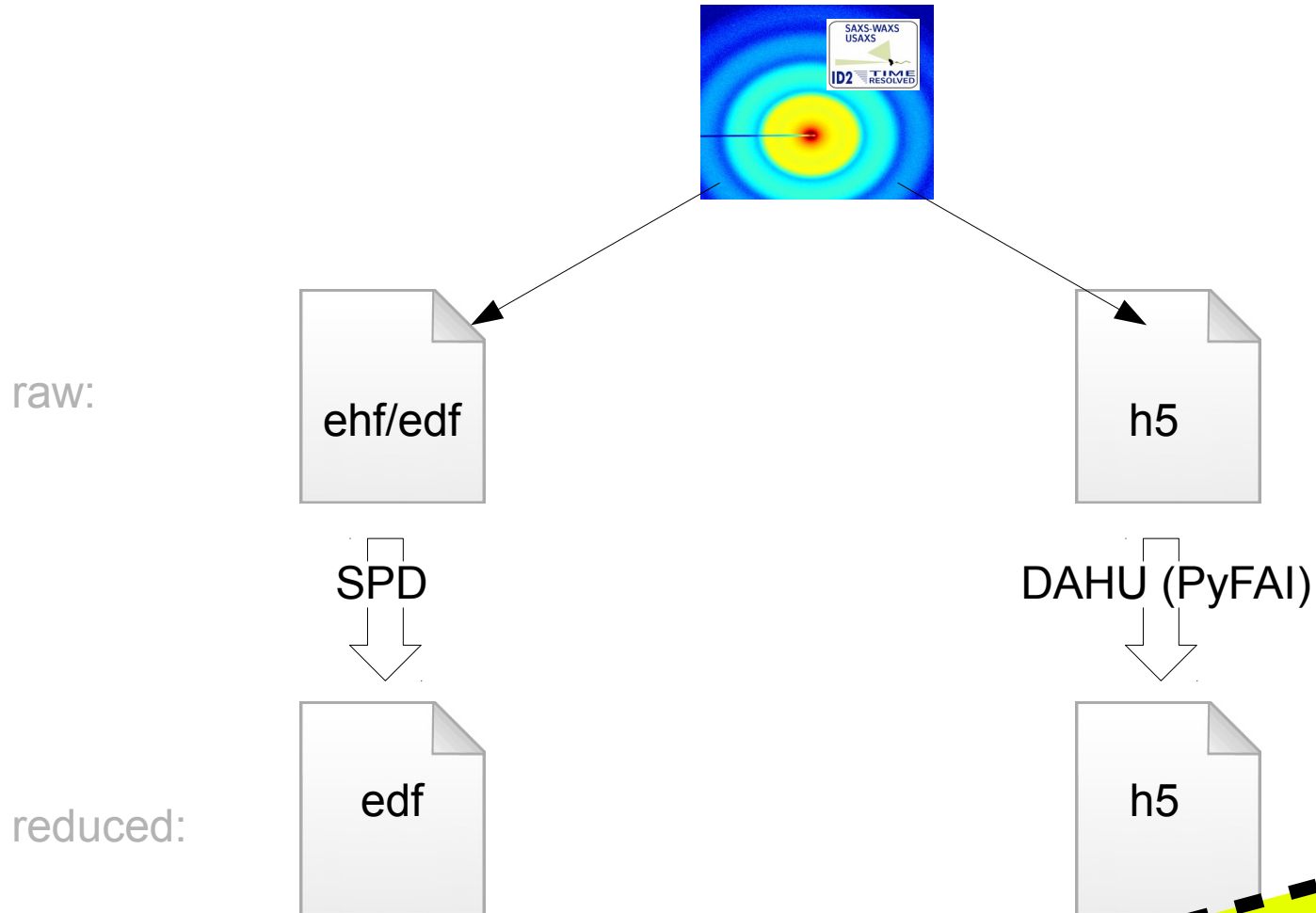


PyFAI is a novel library for azimuthal integration which already provides geometric equivalence with SPD (Bösecke, 2007) and Fit2D (Hammersley et al., 1996).

- designed to reduce SAXS, WAXS and XRPD images into 1D curves (azimuthal integration)
- as a library, the aim of pyFAI is to be integrated into other tools with a clean pythonic interface (e.g. beamline control systems)
- both local and total intensities are conserved in order to obtain accurate quantitative results during the transformation from cartesian space to polar space
- parallelized on graphic cards (GPU)
- shares the geometry definition of SPD
- features also command line tools for batch processing (however not directly compatible with ID02 metadata concept)

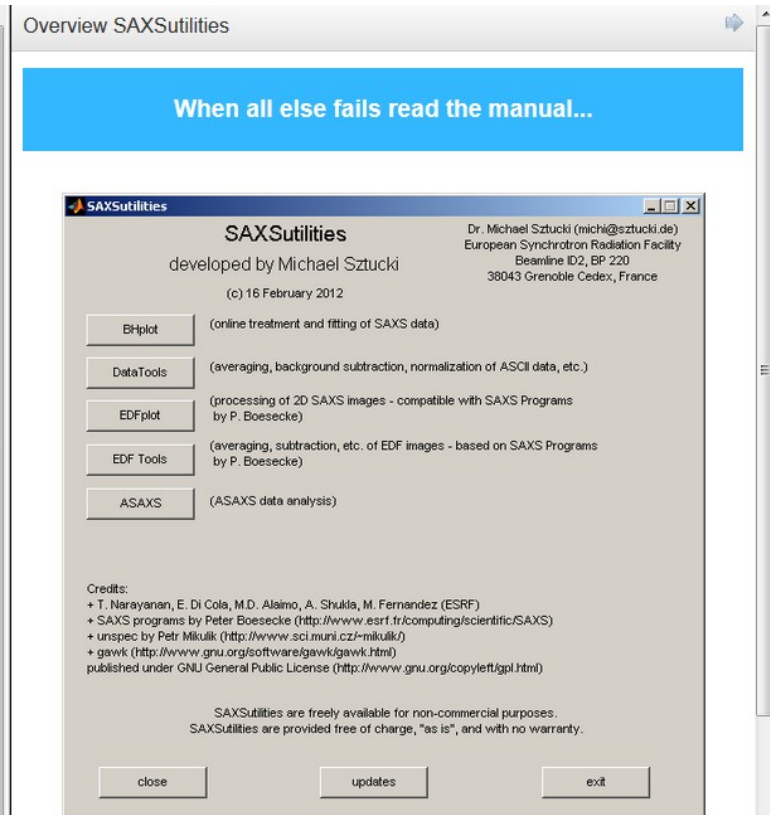
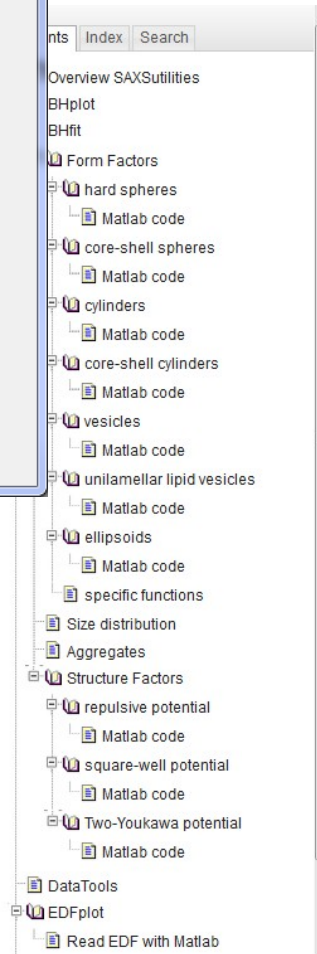
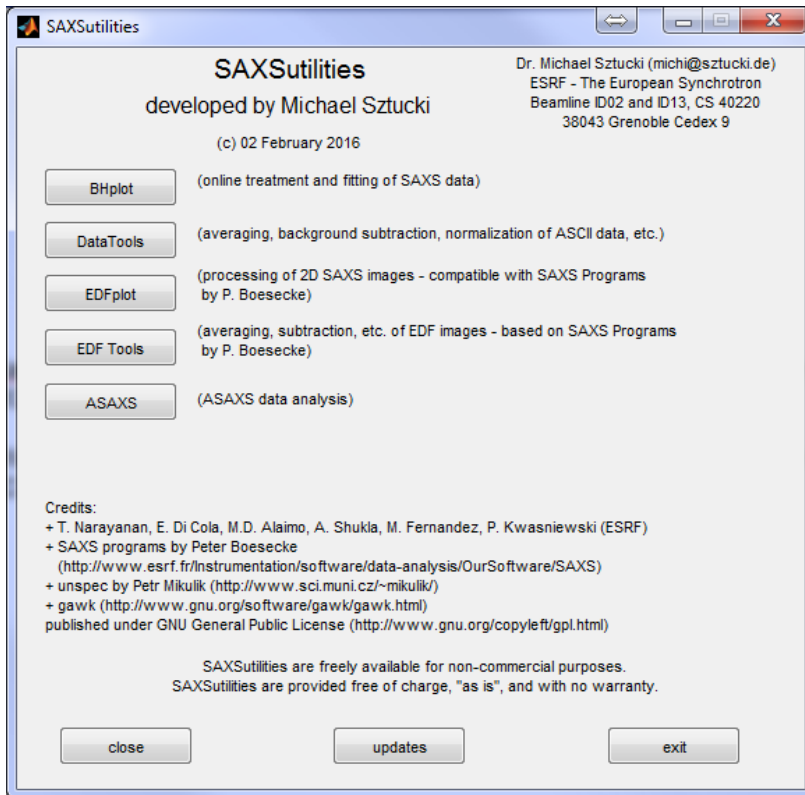
[1] J. Kieffer and D. Karkoulis, PyFAI, a versatile library for azimuthal regrouping, Journal of Physics: Conference Series 425, 202012 (2013)

[2] J. Kieffer and J.P. Wright, PyFAI: a Python library for high performance azimuthal integration on GPU, Powder Diffraction 28, S339 (2013)



two routes for online data reduction

<http://www.saxsutilities.eu>



SAXSutilities (BHplot, DataTools, EDFplot, EDFtools, ASAXS) are Matlab based graphical user interfaces which have been developed for the online processing and analysis of Small Angle (X-ray) Scattering data. They are grouped in the package SAXSutilities which is available in a compiled version (not requiring a Matlab licence) for Windows and Linux (Mac is currently not supported)

Get latest Windows version (WindowsXP, Vista, Windows7, Windows8) :

Download and install program files using the installer (64bit): [SAXSutilitiesSetup64.exe](#)

Do not forget to install the Matlab runtime environment!!

You will be asked at the end of the installation routine to download and install this runtime environment. The installation has to be done only once.

Download 32bit version: [SAXSutilitiesSetup32.exe](#)

This version might not support all features of the 64bit version!!

Get latest Linux version (64-bit only!) (developed under Debian6):

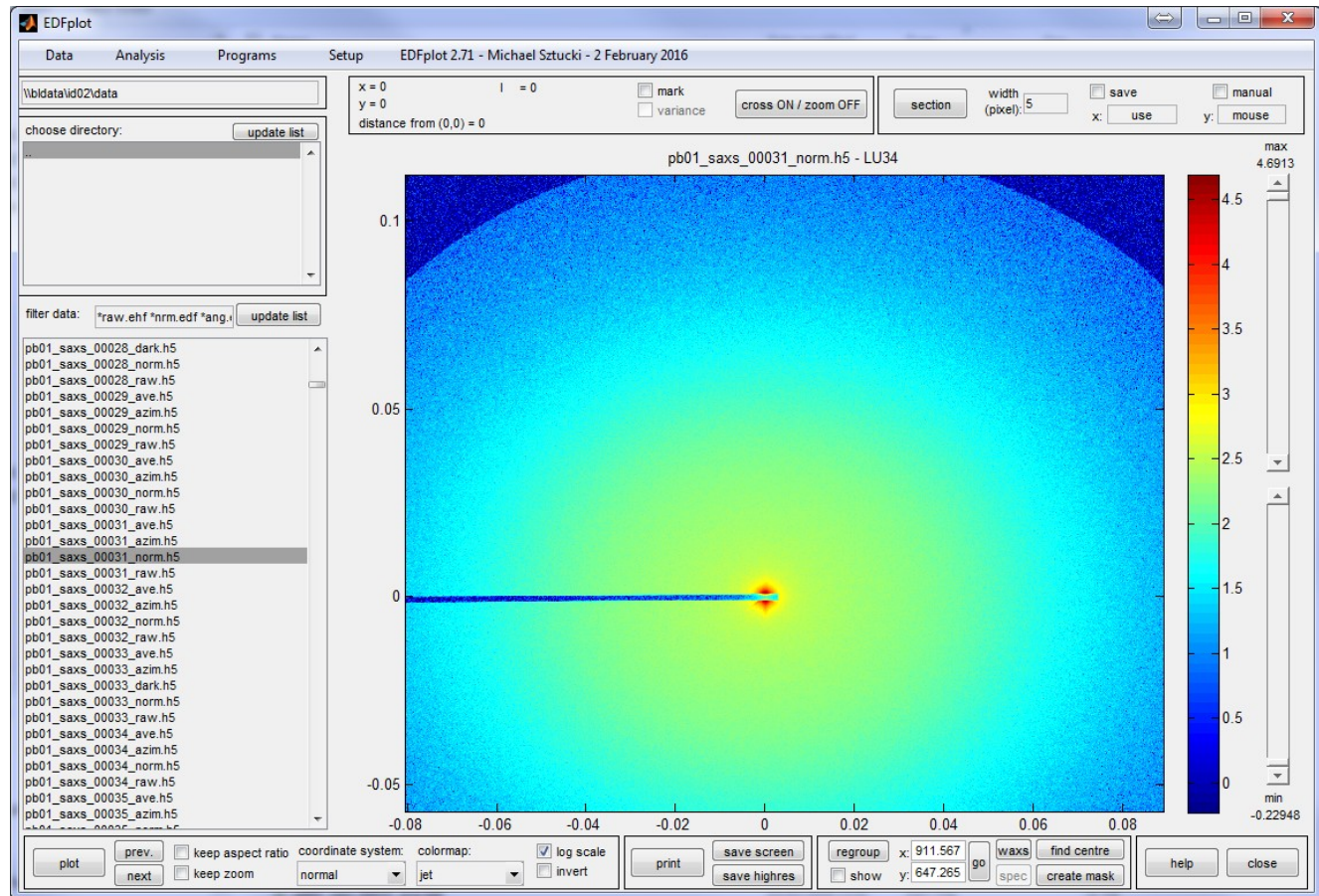
New procedure since October 2013 (Matlab R2013b) !!!

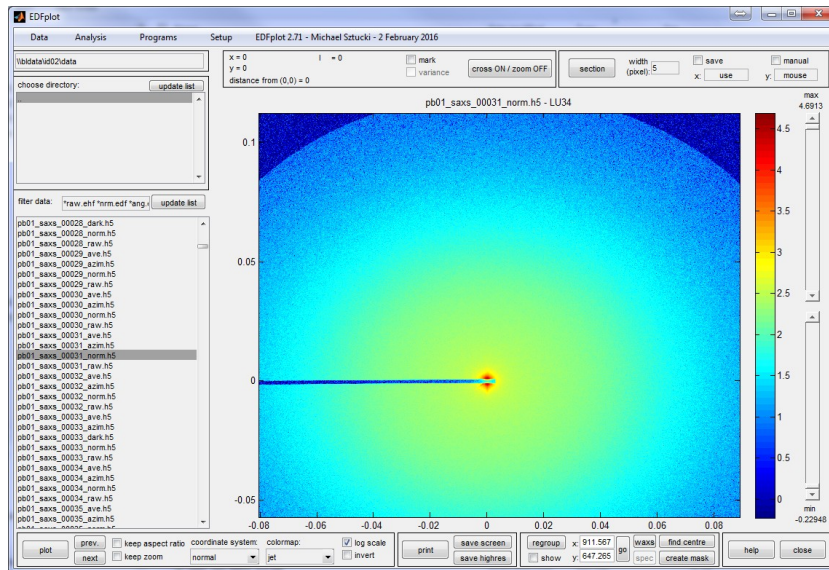
1. Download and unpack to a folder of your choice: [saxsutilities.zip](#)
> unzip saxsutilities.zip
2. Download and unzip: [MCRInstaller2013b_glnxa64.zip](#)
> unzip MCRInstaller2013b_glnxa64.zip
Then, run the MCR Installer script from the directory where you unzipped the package file by entering:
> ./install
Add the environment variables **LD_LIBRARY_PATH** and **XAPPLRESDIR** to your system as indicated in the last step of the installation procedure.
Note that this has to be done only once for each new release of Matlab.
3. Add an environment variable **SAXSUTILITIESPATH** to your system which points to the directory created in step 1.
4. Note that [unspec](#) by P. Mikulik has to be installed.
5. Note that [saxsprogramms](#) by P. Bösecke have to be installed.
6. Note that [roca](#) by P. Bösecke has to be installed. (Since version saxs_V2.461P2.043E2.236R1.500 included in [saxsprogramms](#))
7. Start SAXSutilities from the folder created in step 1.

You can also use a start script like:

```
#!/bin/csh
setenv LD_LIBRARY_PATH [...as indicated by MCRInstaller...]
setenv XAPPLRESDIR [...as indicated by MCRInstaller...]
setenv SAXSUTILITIESPATH [/path/to/directory/of/SAXSutilities]
[/path/to/directory/of/SAXSutilities]/SAXSutilities
```


SAXSutilities – 2D visualisation (EDFplot)





Saxs COORDINATES < ↗ > Saxs PROJECTION

Saxs PROJECTION (scattering pattern on a flat 2D detector)

$$\text{SAXS coordinate} = \frac{(\text{distance of pixel from poni on detector})}{(\text{distance of poni from sample})} \times \frac{\text{wavelength0}}{\text{wavelength}}$$
 where wavelength0 is 1e-9 m

SAXS(Saxs) coordinate ~ s*nm for 2Theta<<1

Waxs PROJECTION (projection of the scattering pattern from the EWALD sphere to a plane perpendicular to the incident beam)

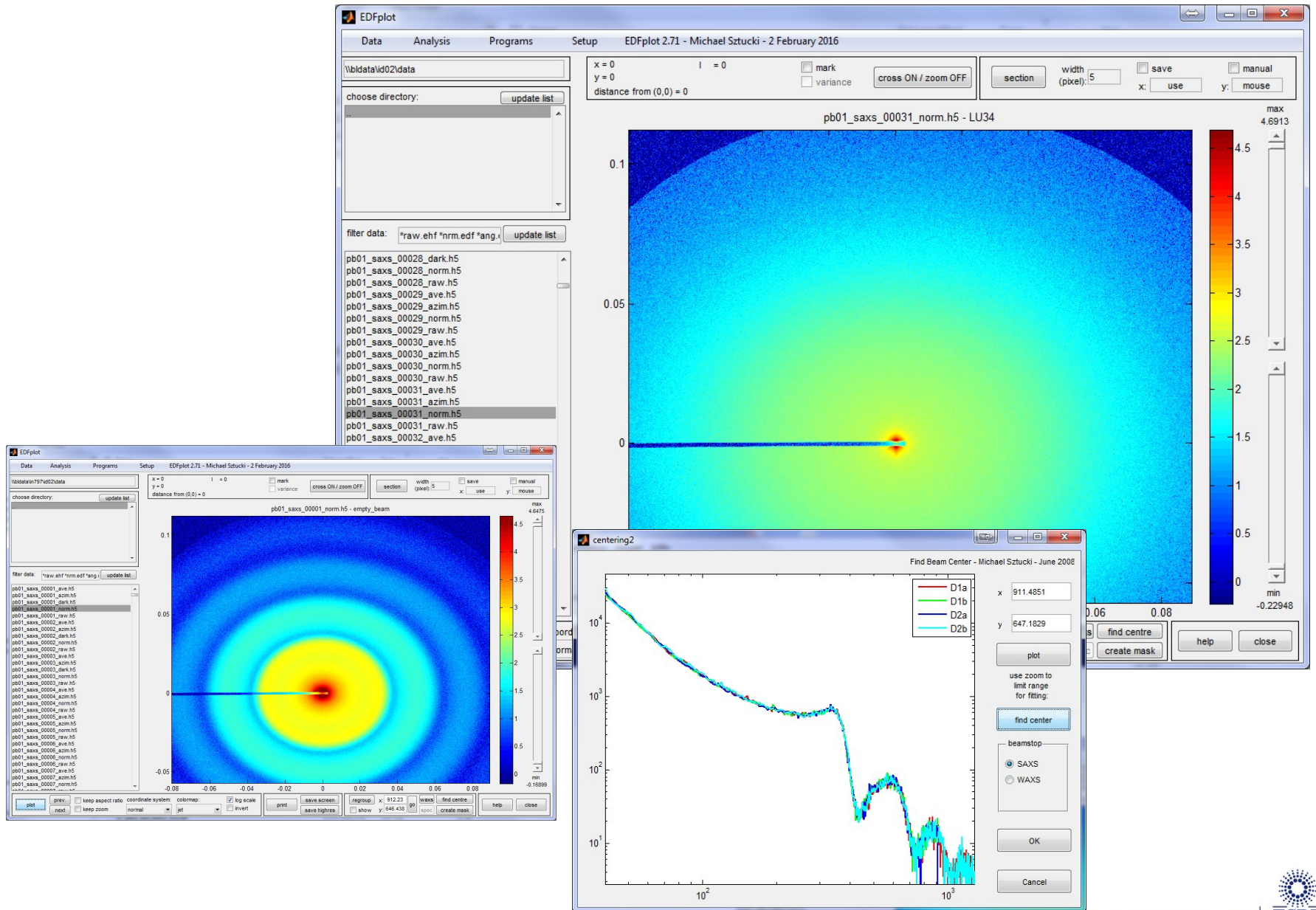
In the Waxs projection, the scattering pattern of the detector is distorted in such a way that the SAXS coordinate of the new pattern is equal to s:

SAXS(Waxs) coordinate = s*nm

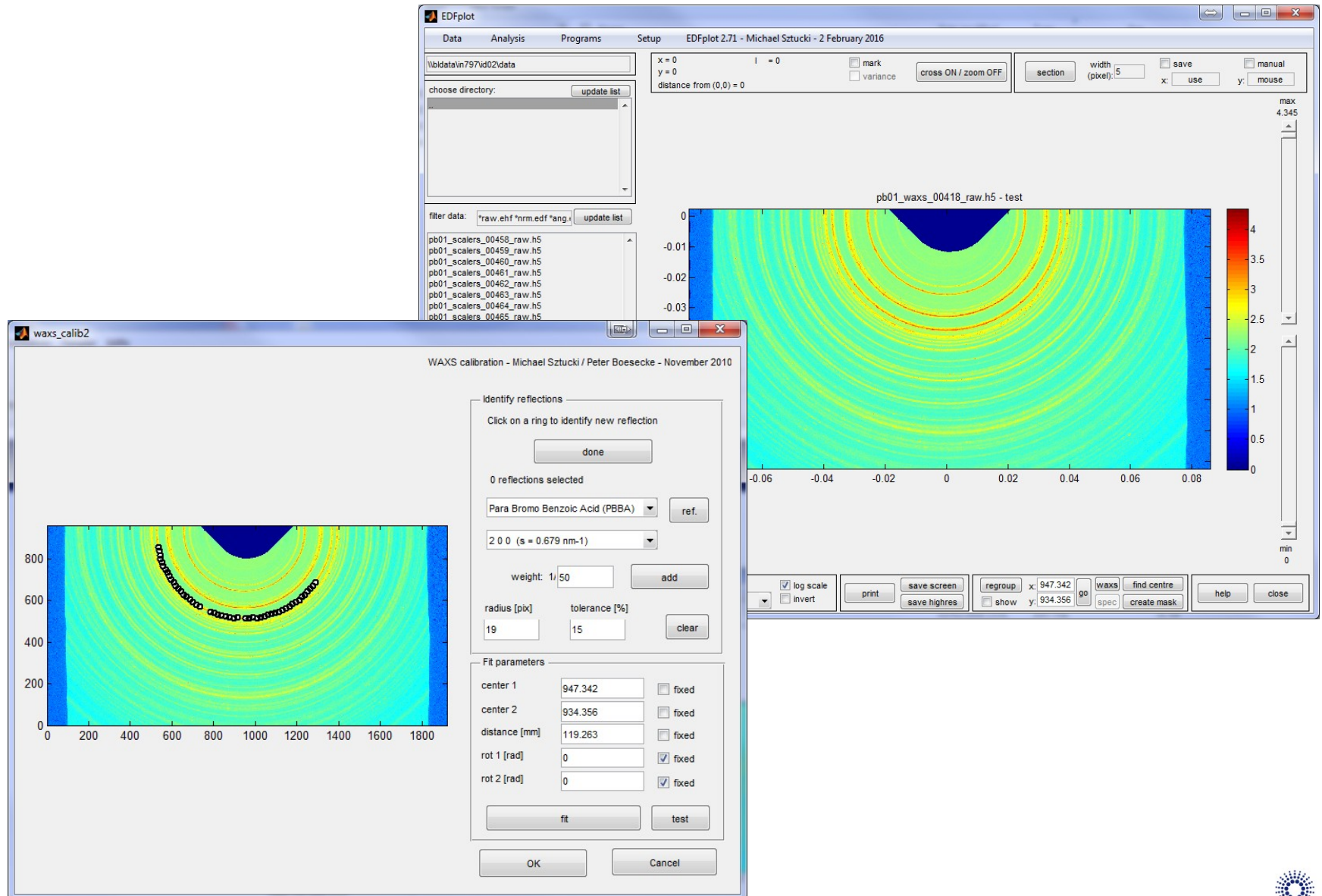
In Waxs PROJECTION the scattering pattern of a tilted detector can be geometrically analysed (azimuthal regrouping etc.) like a small angle scattering pattern.

| Reference system | Applied affine coordinate transformation |
|------------------|--------------------------------------------------------------------------------------------------------------------------------|
| Array | $f_A = f$ |
| Image | $f_I = \text{Offset} + f$ |
| Region | $f_B = (\text{Offset} + f) \times \text{BSize}$ |
| Real | $f_R = (\text{Offset} + f) \times \text{PSize}$ |
| Center | $f_C = \text{Offset} - \text{Center} + f$ |
| Normal | $f_N = (\text{Offset} - \text{Center} + f) \times \text{PSize}$ |
| Saxs | $f_S = \text{Normal}(\text{Offset}, \text{Center}, \text{PSize}, f) / \text{SampleDistance} / (\text{WaveLength} / \text{nm})$ |

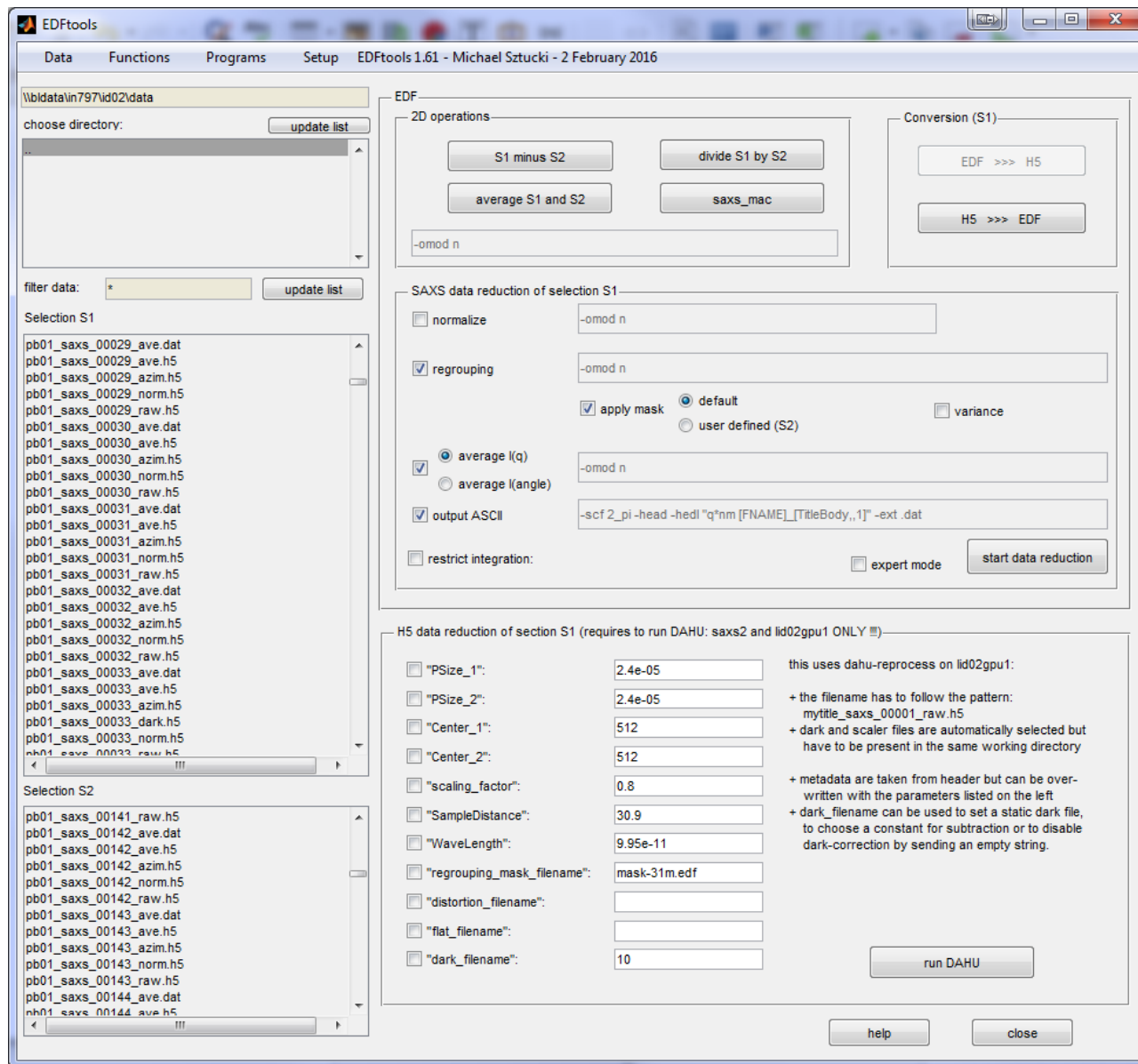
SAXSutilities – 2D visualisation (EDFplot)



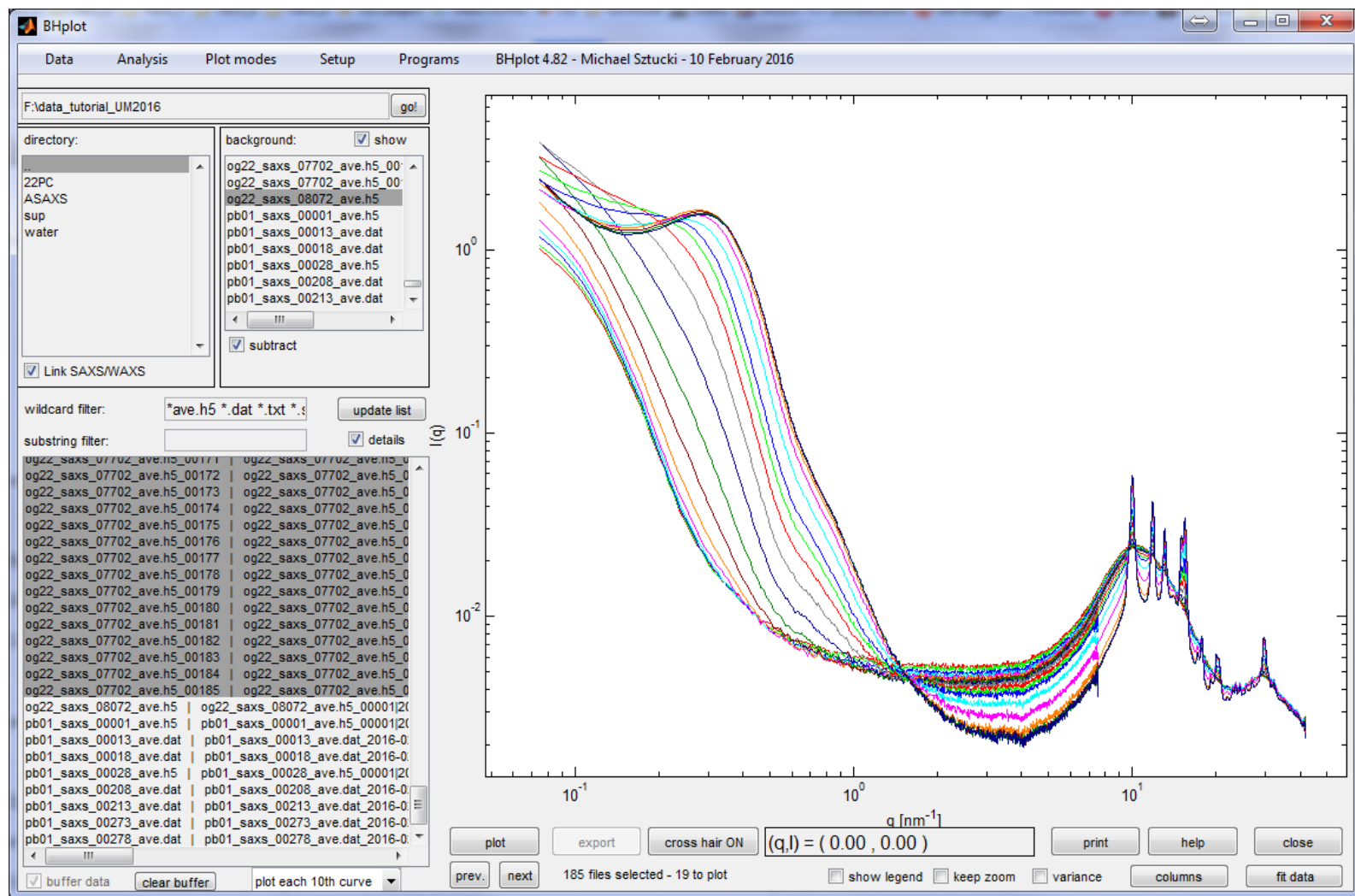
SAXSutilities – 2D visualisation (EDFplot)

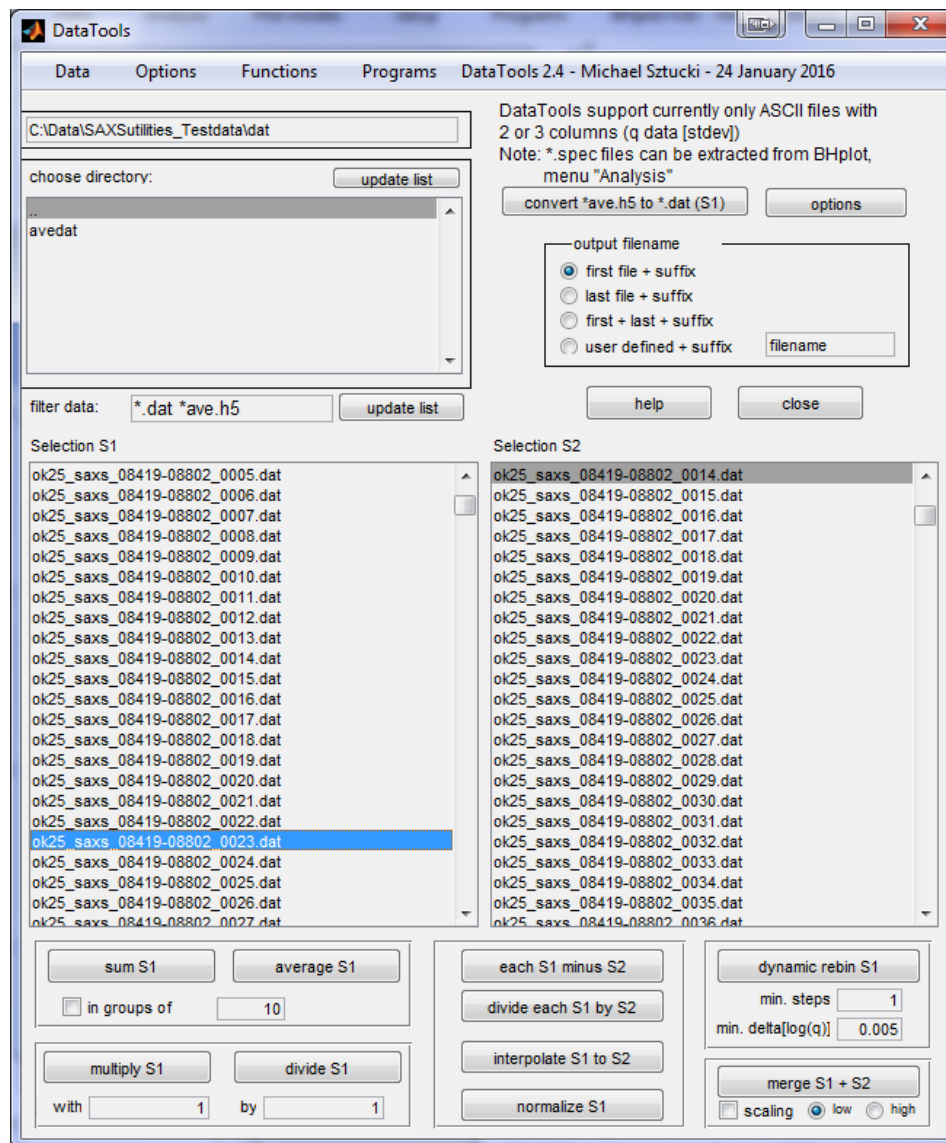


SAXSutilities – 2D tools (EDFtools)

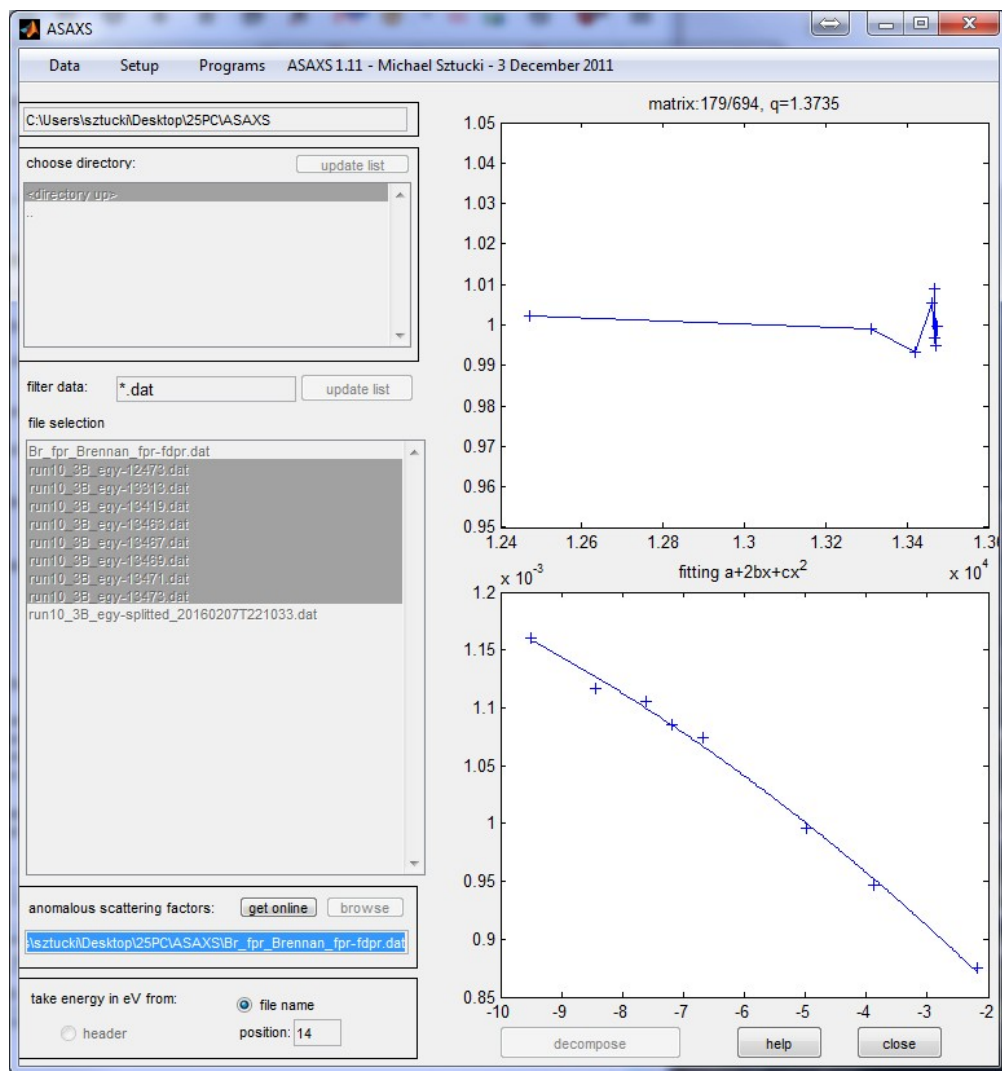


SAXSutilities – 1D visualisation (BHplot)





SAXSutilities – special routines (ASAXS)



The ContrastCalculator software interface includes the following sections:

- Solvent:**
 - Solvent: Water
 - Chemical formula: H₂O
 - Density: 1.0 g / cm³
- Material:**
 - Material: TTAB
 - Chemical formula: C₁₇H₃₈NBr
 - Density: 1.02 g / cm³
- ASAXS contrast (optional):**
 - Ion: Br
 - Ionic radius: 0.182 nm
 - Find online button
- Contrast:**

| Parameter | Value | Unit |
|-------------------------------------------|-------------|------------------|
| mass M: | 336.3928 | g / mol |
| number of electrons N: | 182 | |
| scattering length density: | 0.00093384 | nm ⁻² |
| scattering length density (rel. solvent): | -5.4691e-06 | nm ⁻² |
| electron density: | 332.327 | nm ⁻³ |
| electron density (rel. solvent): | -1.9463 | nm ⁻³ |
| excess electron per ion: | 26.5588 | |
- Buttons:** calculate, help, close

X-ray scattering factor of a single counterion:

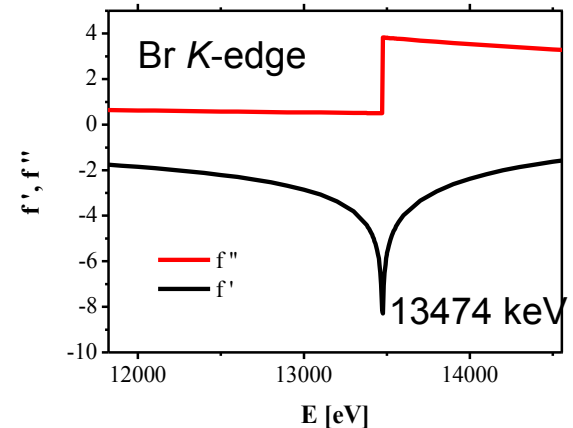
$$\Delta f(E) = \Delta f_0 + f'(E) + if''(E)$$

Energy dependent scattering length density profile:

$$\Delta \rho(r, E) = v(r) r_e \Delta f(E)$$

Scattering amplitude:

$$F(q, E) = F_0(q) + [f'(E) + if''(E)]v(q)$$



$$I(q, E) = F_0^2(q) + 2f'(E)F_0(q)v(q) + [f'^2(E) + f''^2(E)]v^2(q)$$

Total
Intensity

Intensity measured
far below the edge
 \approx SAXS-Intensity

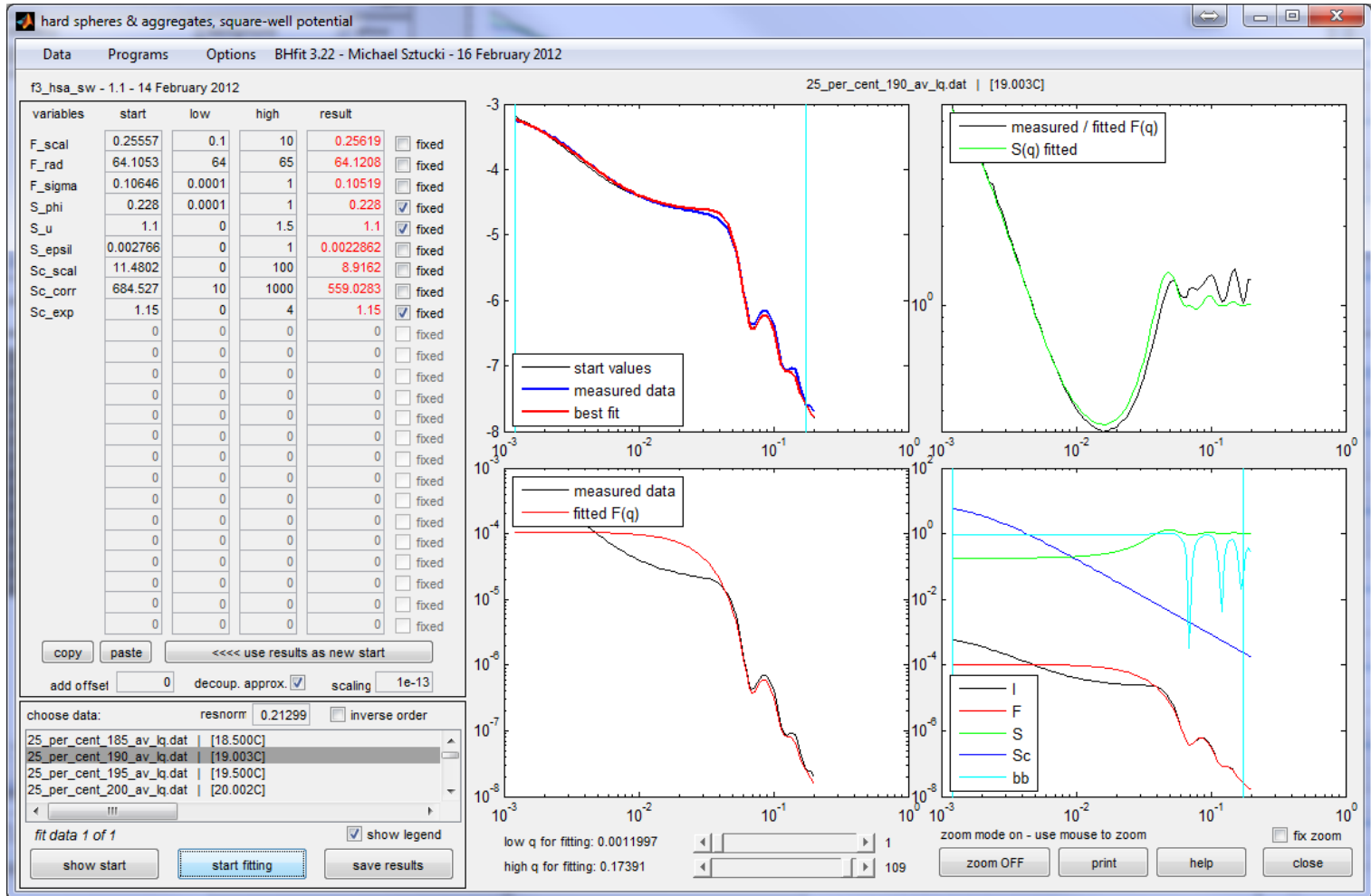
“Cross-term”

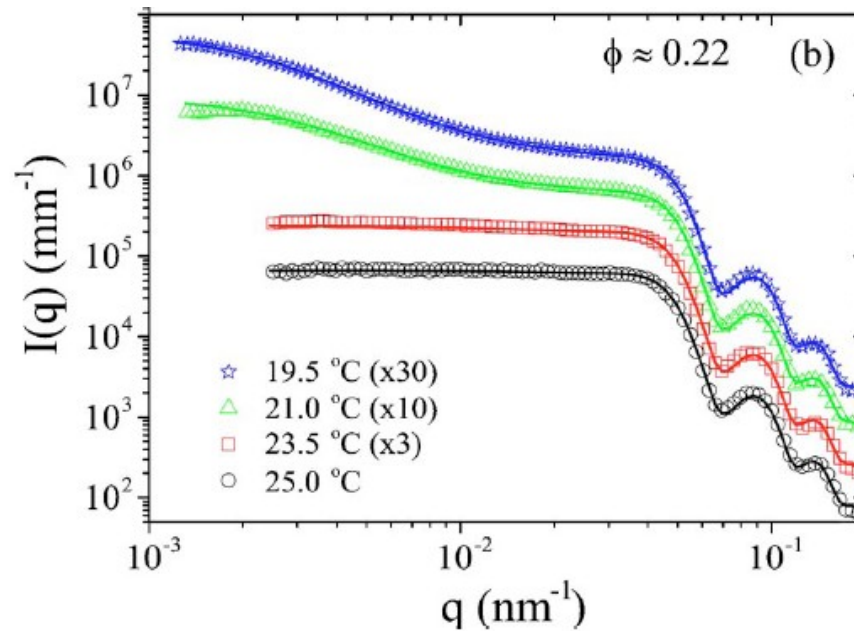
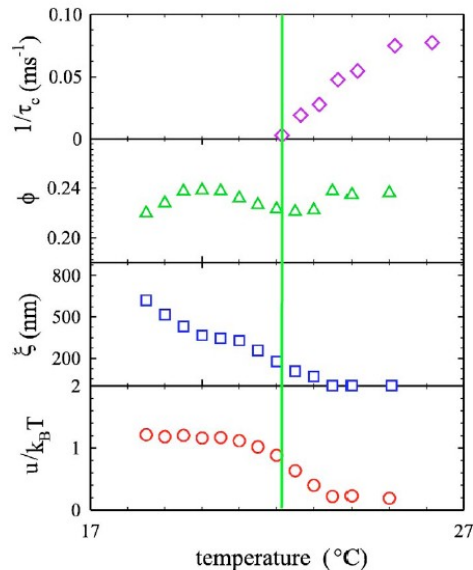
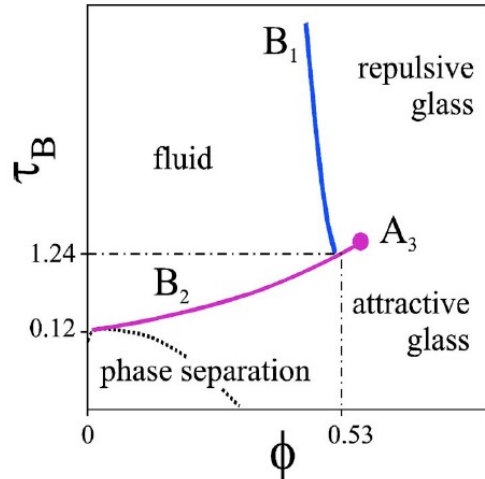
“Self term” of the
counterions

►►► radial distribution of

$F_0(r)$: non-resonant scattering units (macroion + constant part of counterions)

$v(r)$: resonant scattering units (radial distribution of counterions)





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Kinetic arrest and glass-glass transition in short-ranged attractive colloids

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A thermally reversible repulsive hard-sphere to sticky-sphere transition was studied in a model colloidal system over a wide volume fraction range. The static microstructure was obtained from high resolution small angle x-ray scattering, the colloid dynamics was probed by dynamic x-ray and light scattering, and supplementary mechanical properties were derived from bulk rheology. At low concentration, the system shows features of gas-liquid type phase separation. The bulk phase separation is presumably interrupted by a gelation transition at the intermediate volume fraction range. At high volume fractions, fluid-attractive glass and repul-

Online data reduction and analysis are crucial for the productivity of any Small-Angle X-ray Scattering instrument especially when dealing with large amount of data or taking decision during a time-resolved experiment or radiation damage testing. The developed programs and tools do not only work at the ESRF beamline, but can also be installed at the home laboratory for more detailed data analysis.

<http://www.esrf.fr/Instrumentation/software/data-analysis/OurSoftware/SAXS/SaxsDownloads.html>

P. Boesecke, A. Sole, R. Wilcke, J. Kieffer

T. Narayanan and all present and former ID02 staff

BCU (beamline control unit), DAU (data analysis unit)



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